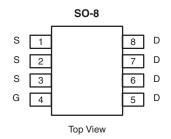




N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)		
30	0.0032 at V _{GS} = 10 V	36	25.5 nC		
	0.0042 at V _{GS} = 4.5 V	29	25.5 110		



Ordering Information: Si4324DY-T1-E3 (Lead (Pb)-free) Si4324DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

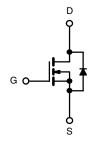
FEATURES

- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested

ROHS COMPLIANT HALOGEN FREE Available

APPLICATIONS

- Synchronous Buck-Low Side
 - Notebook
 - Server
 - Workstation
- Synchronous Rectifier-POL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V _{GS}	± 20	V	
	T _C = 25 °C		36		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	29		
Continuous Diain Current (1) = 150 C)	T _A = 25 °C	1 'b	24 ^{b, c}		
	T _A = 70 °C		19 ^{b, c}	Α	
Pulsed Drain Current		I _{DM}	70		
Continuous Course Busin Binds Courset	T _C = 25 °C	I.	7.0		
Continuous Source-Drain Diode Current	T _A = 25 °C	ls –	3.0 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	40		
Avalanche Energy		E _{AS}	80	mJ	
	T _C = 25 °C		7.8		
Maximum Power Dissipation	T _C = 70 °C	P _D	5.0	w	
	T _A = 25 °C] 'b [3.5 ^{b, c}	VV	
	T _A = 70 °C		2.2 ^{b, c}		
Operating Junction and Storage Temperature	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	29	35	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	13	16] 0, **	

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under Steady State conditions is 80 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					I		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	/T		34		1406	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.4		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	1.4		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ	
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
		$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		0.0025	0.0032	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$		0.0034	0.0042		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 20 A		80		S	
Dynamic ^b	l l				L		
Input Capacitance	c _{iss}			3510			
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		795		pF	
Reverse Transfer Capacitance	c _{rss}			265			
Tabal Oaks Obarras	Q _g	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		55.5	85	nC	
Total Gate Charge				25.5	40		
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		11.6			
Gate-Drain Charge	Q_{gd}			6.6			
Gate Resistance	R_g	f = 1 MHz	0.6	1.25	1.9	Ω	
Turn-on Delay Time	t _{d(on)}			30	45		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		185	280	ns ns	
Turn-Off Delay Time	t _{d(off)}	$V_{DD} = 15 \text{ V}, R_L = 1.5 \Omega$ $I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$		30	45		
Fall Time	t _f	1D = 1071, VGEN = 110 V, 11g = 122		13	20		
Turn-on Delay Time	t _{d(on)}			17	26		
Rise Time	t _r	V 15VD 150		90	140		
Turn-Off Delay Time	t _{d(off)}	V_{DD} = 15 V, R_L = 1.5 Ω $I_D \cong$ 10 A, V_{GEN} = 10 V, R_α = 1 Ω		37	56		
Fall Time	t _f	1D = 1071, VGEN = 10 V, 11g = 132		10	16		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			7	A	
Pulse Diode Forward Current ^a	I _{SM}				70		
Body Diode Voltage	V_{SD}	I _S = 3 A		0.72	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			40	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 12 A dl/dt = 100 A/vo T = 05 °C		40	60	nC	
Reverse Recovery Fall Time	t _a	$I_F = 13 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		21		- ns	
Reverse Recovery Rise Time	t _b			+			

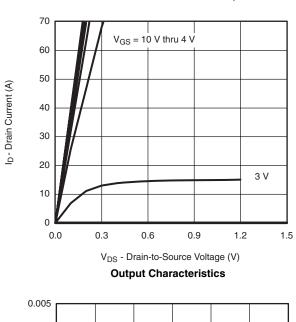
Notes:

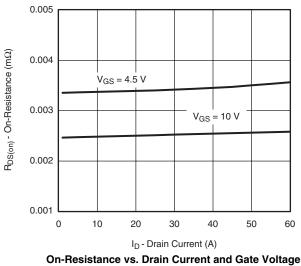
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing.

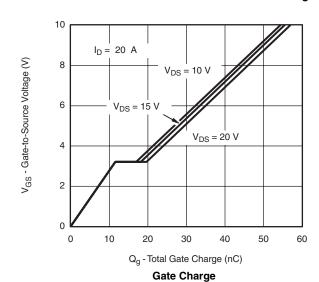
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

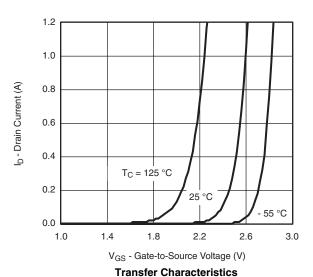


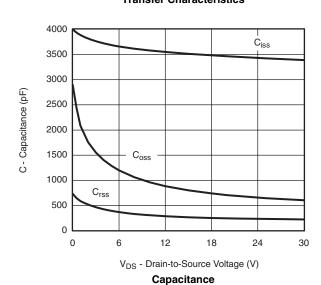
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

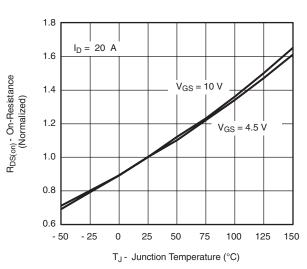






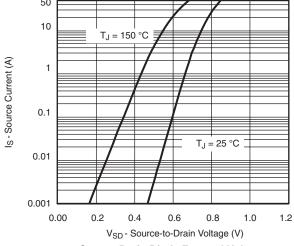


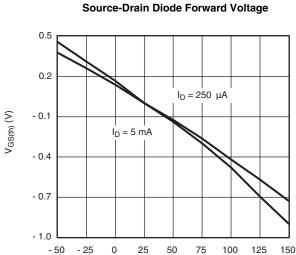




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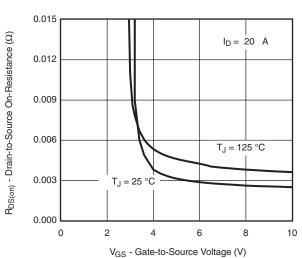
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



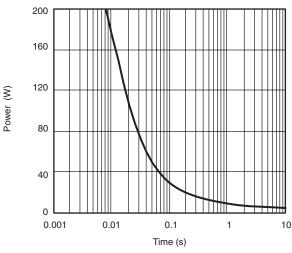


T_{.I} - Temperature (°C)

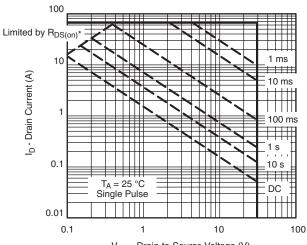
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

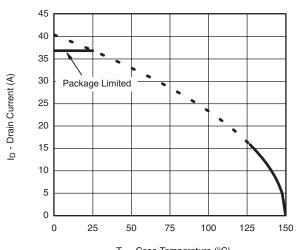


V_{DS} - Drain-to-Source Voltage (V) * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

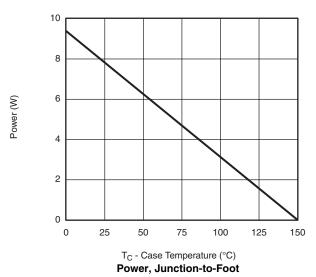


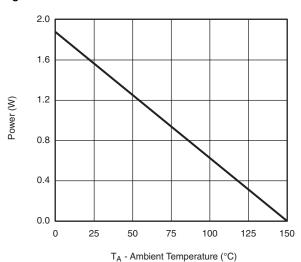
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





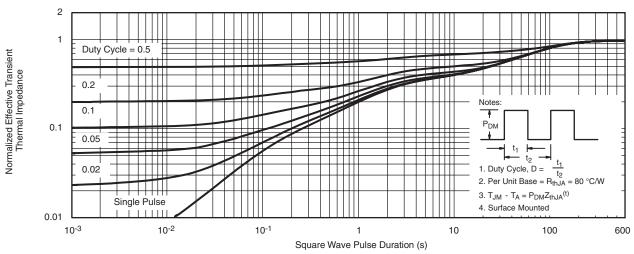
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

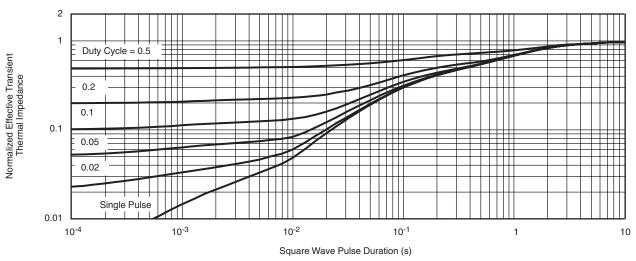
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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